

MTP4413Q8-VB Datasheet P-Channel 20-V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}$ (Ω)	I _D (A)	Q _g (Typ.)		
	0.015 at $V_{GS} = -4.5 \text{ V}$	- 13 ^a			
- 20	0.021 at $V_{GS} = -2.5 \text{ V}$	- 10 ^a	20 nC		
	0.040 at V _{GS} = - 1.8 V	- 8			

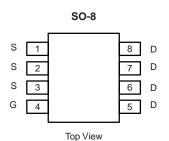
FEATURES

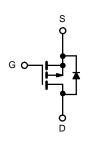
- Halogen-free According to IEC 61249-2-21 Definition

- Trench Power MOSFET 100 % $R_{\rm g}$ Tested Compliant to RoHS Directive 2002/95/EC



FREE





P-Channel MOSFET

APPLICATIONS

- Portable Devices
 - Load Switch
 - Battery Switch
 - Charger Switch

ABSOLUTE MAXIMUM RATINGS	T _A = 25 °C, unles	ss otherwise not	ted	
Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V _{DS}	- 20	V	
Gate-Source Voltage	V_{GS}	± 12	¬	
	T _C = 25 °C		- 13 ^a	
Continuous Drain Current (T _{.1} = 150 °C)	$T_C = 70 ^{\circ}C$	I_	- 10 ^a	
Continuous Diam Current (1) = 100 °C)	T _A = 25 °C	I _D	- 8 ^{b, c}	
	T _A = 70 °C		- 7.1 ^{b, c}	Α
Pulsed Drain Current	I _{DM}	- 50		
Continuous Source-Drain Diode Current	$T_C = 25 ^{\circ}C$	I _S	- 6 ^a	
Continuous Course Brain Blode Current	T _A = 25 °C	'S	- 2.9 ^{b, c}	
	$T_C = 25 ^{\circ}C$		19	
Maximum Power Dissipation	$T_C = 70 ^{\circ}C$	P _D	12	W
Maximum r ower bissipation	$T_A = 25 ^{\circ}C$, р	3.5 ^{b, c}	
	T _A = 70 °C		2.2 ^{b, c}	
Operating Junction and Storage Temperature Ra	T _J , T _{stg}	- 55 to 150	°C	
Soldering Recommendations (Peak Temperature		260		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, e}	t ≤ 5 s	R _{thJA}	28	36	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	R_{thJC}	5.3	6.5	O/ VV	

Notes:

- a. Package limited.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 5 s.
- d. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.
- e. Maximum under Steady State conditions is 80 °C/W.



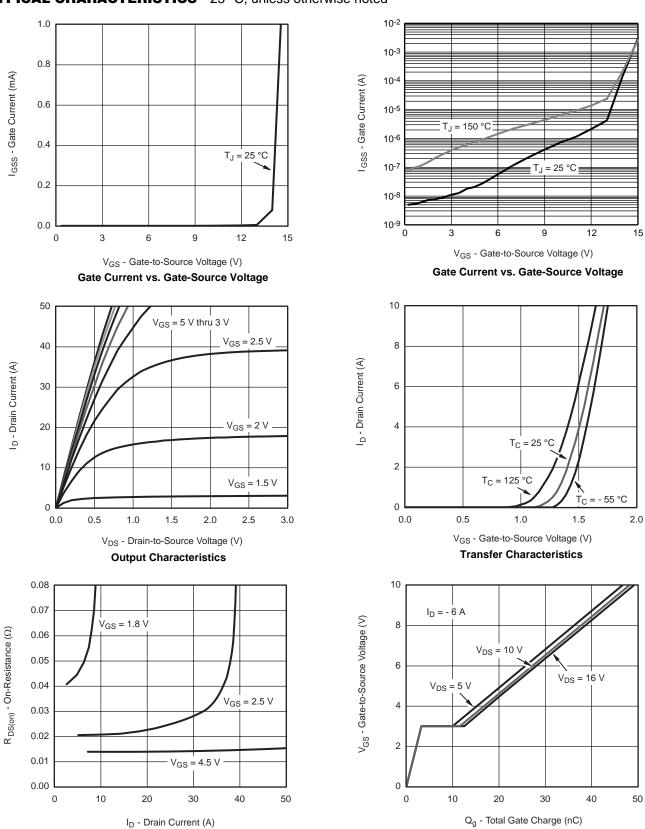
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	- 20			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = - 250 μA		- 12		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$			3			
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \mu\text{A}$	- 0.5		- 1.2	V	
Cata Cauras I salvasa	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 12 \text{ V}$			± 20		
Gate-Source Leakage		$V_{DS} = 0 \text{ V}, V_{GS} = \pm 4.5 \text{ V}$			± 0.5	4	
Zara Cata Valtaga Drain Current	,	V _{DS} = - 20 V, V _{GS} = 0 V			- 1	μΑ	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = - 20 V, V _{GS} = 0 V, T _J = 55 °C			- 10		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le -5 \text{ V}, V_{GS} = -4.5 \text{ V}$	- 20			Α	
		$V_{GS} = -4.5 \text{ V}, I_D = -5.6 \text{ A}$		0.015		Ω	
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = -2.5 \text{ V}, I_D = -5.3 \text{ A}$		0.021			
		V _{GS} = - 1.8 V, I _D = - 2.5 A		0.040			
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 10 V, I _D = - 5.6 A		35		S	
Dynamic ^b							
Total Gate Charge		V _{DS} = - 10 V, V _{GS} = - 8 V, I _D = - 5 A		50	75		
	Q_g			20	30	nC	
Gate-Source Charge	Q_{gs}	$V_{DS} = -10 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -5 \text{ A}$		3.3			
Gate-Drain Charge	Q_{gd}			8.4			
Gate Resistance	R_{g}	f = 1 MHz	0.2	1	2	kΩ	
Turn-On Delay Time	t _{d(on)}			0.71	1.1		
Rise Time	t _r	V_{DD} = - 10 V, R_L = 1 Ω		1.7	2.6		
Turn-Off Delay Time		$I_D \cong$ - 5 A, V_{GEN} = - 4.5 V, R_g = 1		6	9		
Fall Time	t _f	Ω		3.2	5	Ī	
Turn-On Delay Time	t _{d(on)}			0.3	0.45	us	
Rise Time	t _r	V_{DD} = - 10 V, R_L = 1 Ω		0.6	0.9		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong$ - 5 A, $V_{GEN} =$ - 10 V, $R_g = 1$		10	15		
Fall Time	t _f	Ω		3.5	5.5		
Drain-Source Body Diode Characterist	ics			•	l		
Continuous Source-Drain Diode Current	I _S	$T_C = 25 ^{\circ}C$			- 6	Α	
Pulse Diode Forward Current	I _{SM}				- 50	_ ^	
Body Diode Voltage	V_{SD}	I _S = - 5 A, V _{GS} = 0 V		- 0.85	- 1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			30	60	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	L = 6 A dl/dt = 100 A/vs T = 25 °C		20	40	nC	
Reverse Recovery Fall Time	t _a	$I_F = 6 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 \text{ °C}$		13		ns	
Reverse Recovery Rise Time	t _b			17			

Notes:

- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$ b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



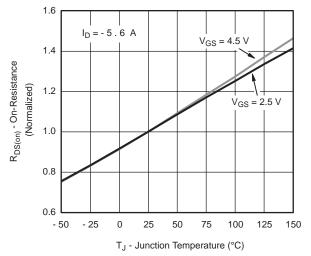


服务热线:400-655-8788

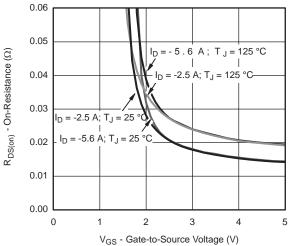
On-Resistance vs. Drain Current

Gate Charge

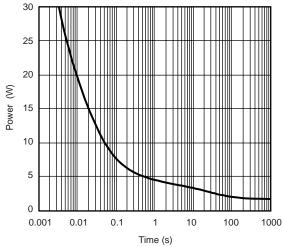




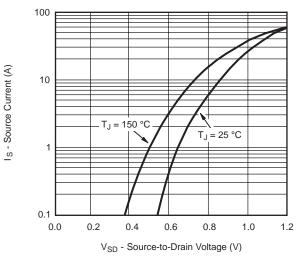
On-Resistance vs. Junction Temperature



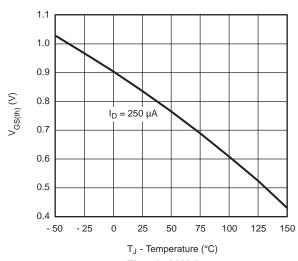
On-Resistance vs. Gate-to-Source Voltage



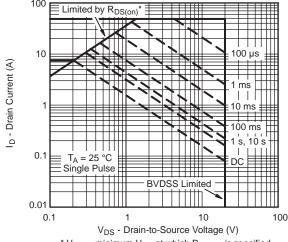
Single Pulse Power, Junction-to-Ambient



Soure-Drain Diode Forward Voltage



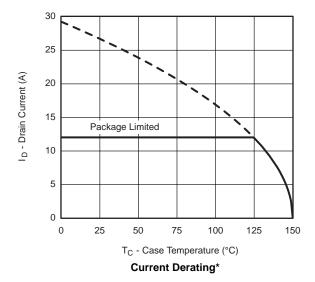
Threshold Voltage

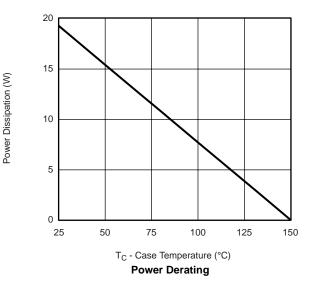


* V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

Safe Operating Area, Junction-to-Ambient

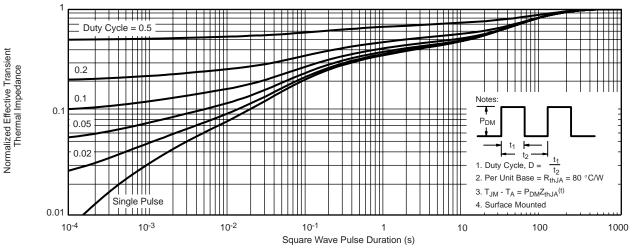




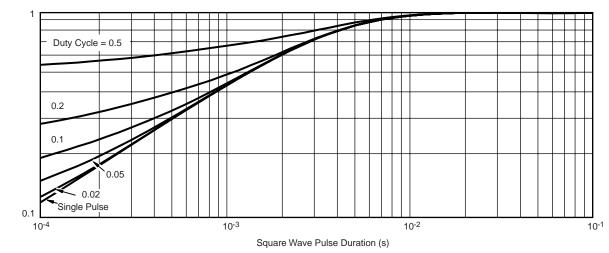


^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Ambient

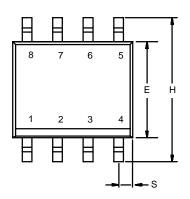


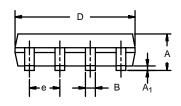
Normalized Thermal Transient Impedance, Junction-to-Case

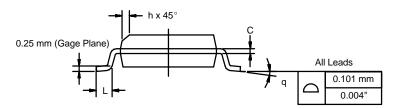
Normalized Effective Transient Thermal Impedance



SOIC (NARROW): 8-LEADJEDEC Part Number: MS-012







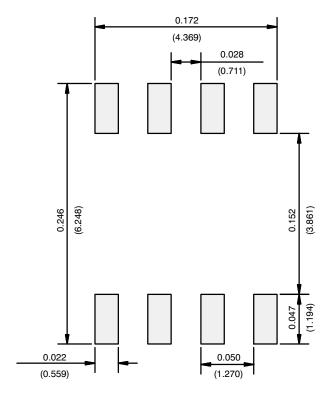
	MILLIM	MILLIMETERS INCHES			
DIM	Min	Max	Min	Max	
Α	1.35	1.75	0.053	0.069	
A ₁	0.10	0.20	0.004	0.008	
В	0.35	0.51	0.014	0.020	
С	0.19	0.25	0.0075	0.010	
D	4.80	5.00	0.189	0.196	
E	3.80	4.00	0.150	0.157	
е	1.27 BSC		0.050 BSC		
Н	5.80	6.20	0.228	0.244	
h	0.25	0.50	0.010	0.020	
L	0.50	0.93	0.020	0.037	
q	0°	8°	0°	8°	
S	0.44	0.64	0.018	0.026	
FCN: C-06527-Rev I 11-Sen-06					

ECN: C-06527-Rev. I, 11-Sep-06

DWG: 5498



RECOMMENDED MINIMUM PADS FOR SO-8



Recommended Minimum Pads Dimensions in Inches/(mm)



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